

SiC JFET Division

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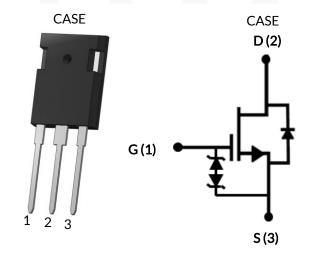








UF3C170400K3S



Part Number	Package	Marking		
UF3C170400K3S	TO-247-3L	UF3C170400K3S		









Silicon Carbide (SiC) Cascode JFET -EliteSiC, Power N-Channel, TO-247-3L, 1700 V, 410 mohm

Rev. B, January 2025

Description

This SiC FET device is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the TO-247-3L package, this device exhibits ultralow gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads , and any application requiring standard gate drive.

Features

- Typical on-resistance $R_{DS(on),typ}$ of $410m\Omega$
- Maximum operating temperature of 175°C
- Excellent reverse recovery
- Low gate charge
- Low intrinsic capacitance
- ESD protected, HBM class 2

Typical applications

- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating













Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	V_{DS}		1700	V
Gate-source voltage	V_{GS}	DC	-25 to +25	V
Continuous drain current ¹		T _C = 25°C	7.6	Α
Continuous drain current	I _D	T _C = 100°C	5.9	Α
Pulsed drain current ²	I _{DM}	T _C = 25°C	14	Α
Single pulsed avalanche energy ³	E _{AS}	L=15mH, I _{AS} =1.25A	11.7	mJ
Power dissipation	P _{tot}	T _C = 25°C	100	W
Maximum junction temperature	$T_{J,max}$		175	°C
Operating and storage temperature	T_J, T_{STG}		-55 to 175	°C
Max. lead temperature for soldering, 1/8" from case for 5 seconds	T _L		250	°C

- 1. Limited by $T_{J,\text{max}}$
- 2. Pulse width t_p limited by $T_{J,max}$
- 3. Starting $T_J = 25^{\circ}C$

Thermal Characteristics

Parameter	Symbol	Test Conditions	Value		Units	
			Min	Тур	Max	Offics
Thermal resistance, junction-to-case	$R_{\theta JC}$			1.2	1.5	°C/W













Electrical Characteristics (T_J = +25°C unless otherwise specified)

Typical Performance - Static

Parameter	Symbol	Test Conditions		Unite		
Parameter	Parameter Symbol		Min	Тур	Max	- Units
Drain-source breakdown voltage	BV _{DS}	$V_{GS}=0V, I_D=1mA$	1700			V
Total drain leakage current	I _{DSS}	V _{DS} =1700V, V _{GS} =0V, T _J =25°C		1.5	60	μΑ
		V _{DS} =1700V, V _{GS} =0V, T _J =175°C		5.5		
Total gate leakage current	I _{GSS}	V _{DS} =0V, T _J =25°C, V _{GS} =-20V / +20V		6	±20	μΑ
Drain-source on-resistance	R _{DS(on)}	V _{GS} =12V, I _D =5A, T _J =25°C		410	515	mΩ
Drain source on resistance		V _{GS} =12V, I _D =5A, T _J =175°C		1070		11122
Gate threshold voltage	$V_{G(th)}$	V_{DS} =5V, I_D =10mA	3	4.7	6	V
Gate resistance	R_{G}	f=1MHz, open drain		4.1		Ω

Typical Performance - Reverse Diode

Davamatas	Symbol	Test Conditions		Units		
Parameter			Min	Тур	Max	Units
Diode continuous forward current ¹	I _S	T _C =25°C			7.6	Α
Diode pulse current ²	I _{S,pulse}	T _C =25°C			14	А
Forward voltage	V _{FSD}	V _{GS} =0V, I _F =2A, T _J =25°C		1.5	1.75	V
		V _{GS} =0V, I _F =2A, T _J =175°C		2.4		
Reverse recovery charge	Q _{rr}	$V_R = 1200V, I_F = 5A,$ $V_{GS} = -5V, R_{G_EXT} = 10\Omega$		70		nC
Reverse recovery time	t _{rr}	di/dt=4000A/μs, T _J =25°C		29		ns
Reverse recovery charge	Q _{rr}	V_R =1200V, I_F =5A, V_{GS} =-5V, R_{G_EXT} =10 Ω		67		nC
Reverse recovery time	t _{rr}	di/dt=4000A/μs, Τ _J =150°C		27		ns













Typical Performance - Dynamic

Parameter	Symbol Tost Co	Test Conditions		Value		
Parameter	Symbol	rest Conditions	Min	Тур	Max	Units
Input capacitance	C _{iss}	- V _{DS} =100V, V _{GS} =0V - f=100kHz		740		
Output capacitance	C _{oss}			27		pF
Reverse transfer capacitance	C_{rss}	1-100KHZ		2		
Effective output capacitance, energy related	C _{oss(er)}	V_{DS} =0V to 1200V, V_{GS} =0V		15.5		pF
Effective output capacitance, time related	C _{oss(tr)}	V_{DS} =0V to 1200V, V_{GS} =0V		28		pF
C _{OSS} stored energy	E _{oss}	V _{DS} =1200V, V _{GS} =0V		11.2		μЈ
Total gate charge	Q_G	- V _{DS} =1200V, I _D =5A, - V _{GS} = -5V to 15V		27.5		nC ns
Gate-drain charge	Q_{GD}			6.5		
Gate-source charge	Q_{GS}			10		
Turn-on delay time	$t_{d(on)}$	V_{DS} =1200V, I_{D} =5A, Gate Driver =-5V to +15V, Turn-on $R_{G,EXT}$ =1 Ω , Turn-off $R_{G,EXT}$ =22 Ω Inductive Load, FWD: same device with		17		
Rise time	t _r			13		
Turn-off delay time	t _{d(off)}			34		
Fall time	t _f			27		
Turn-on energy	E _{ON}			189		
Turn-off energy	E _{OFF}	V_{GS} = -5V and R_G = 10 Ω ,		43		
Total switching energy	E _{TOTAL}	T _J =25°C		232		
Turn-on delay time	t _{d(on)}	V _{DS} =1200V, I _D =5A, Gate		17		
Rise time	t _r	Driver =-5V to +15V,		11		
Turn-off delay time	t _{d(off)}	Turn-on $R_{G,EXT}$ =1 Ω , Turn-off $R_{G,EXT}$ =22 Ω		35		ns
Fall time	t _f			28		
Turn-on energy	E _{ON}	Inductive Load, FWD: same device with		158		
Turn-off energy	E _{OFF}	V_{GS} = -5V and R_G = 10 Ω ,		50		μJ
Total switching energy	E _{TOTAL}	T _J =150°C		208		





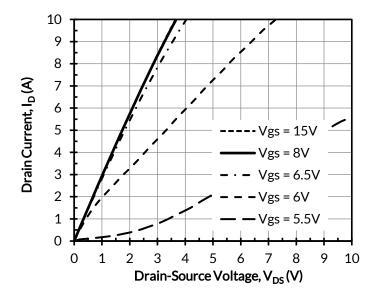








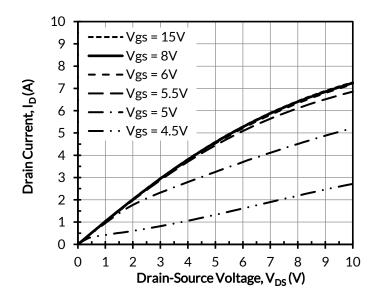
Typical Performance Diagrams



10 9 8 Drain Current, I_D (A) 7 6 5 Vgs = 15V 4 Vgs = 8V 3 - Vgs = 6V 2 - Vgs = 5.5V 1 Vgs = 5V 0 0 2 3 5 10 1 Drain-Source Voltage, V_{DS} (V)

Figure 1. Typical output characteristics at $T_J = -55$ °C, tp < 250 μ s

Figure 2. Typical output characteristics at $T_J = 25$ °C, tp < 250 μ s



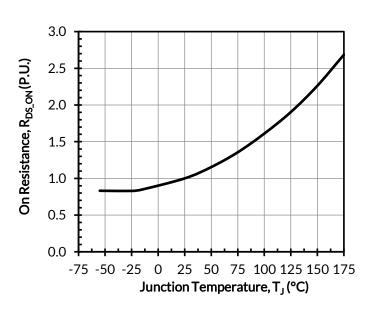


Figure 3. Typical output characteristics at T_J = 175°C, tp < 250 μ s

Figure 4. Normalized on-resistance vs. temperature at V_{GS} = 12V and I_{D} = 5A



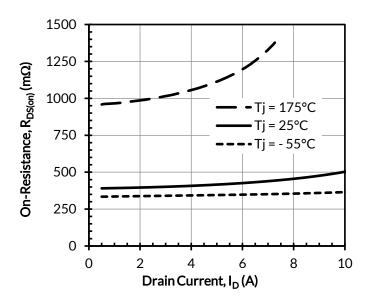








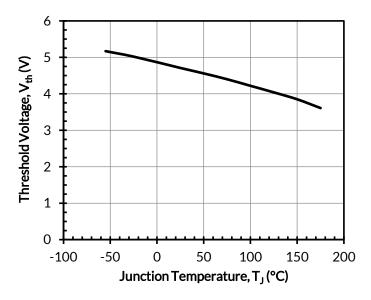




Tj = -55°C Tj = 25°C Tj = 175°C Drain Current, I_D (A) Gate-Source Voltage, $V_{GS}(V)$

Figure 5. Typical drain-source on-resistances at V_{GS} = 12V

Figure 6. Typical transfer characteristics at V_{DS} = 5V



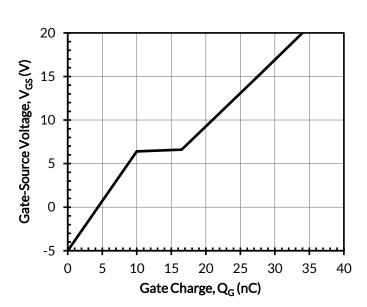


Figure 7. Threshold voltage vs. junction temperature at V_{DS} = 5V and I_{D} = 10mA

Figure 8. Typical gate charge at V_{DS} = 1200V and I_{D} = 5A













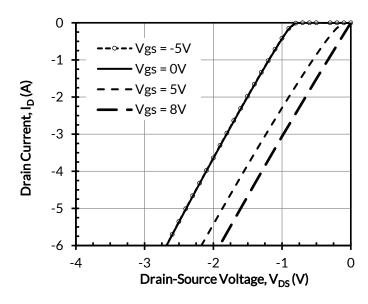


Figure 9. 3rd quadrant characteristics at $T_J = -55$ °C

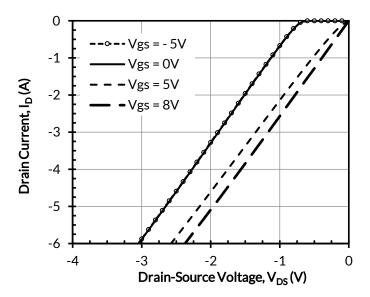


Figure 10. 3rd quadrant characteristics at T_J = 25°C

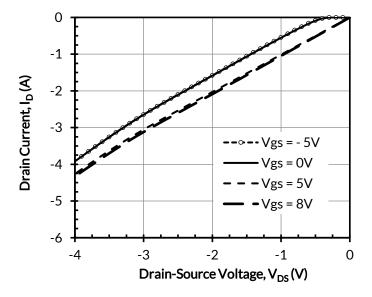


Figure 11. 3rd quadrant characteristics at $T_J = 175$ °C

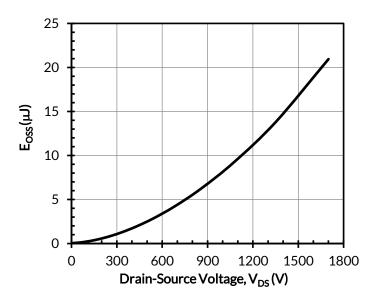


Figure 12. Typical stored energy in C_{OSS} at $V_{GS} = 0V$













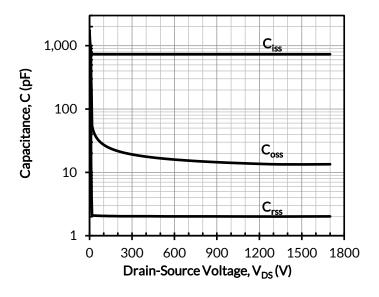


Figure 13. Typical capacitances at f = 100kHz and $V_{GS} = 0V$

Figure 14. DC drain current derating

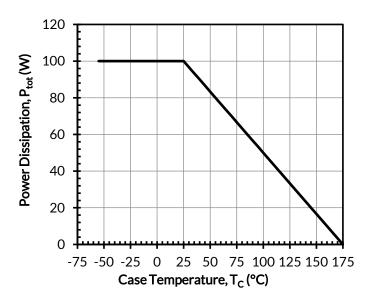


Figure 15. Total power dissipation

Figure 16. Maximum transient thermal impedance













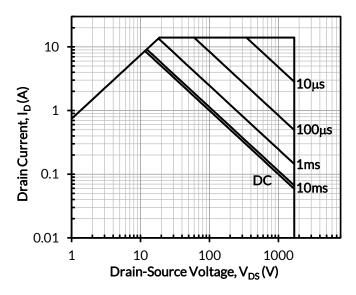


Figure 17. Safe operation area at $T_C = 25$ °C, D = 0, Parameter t_p

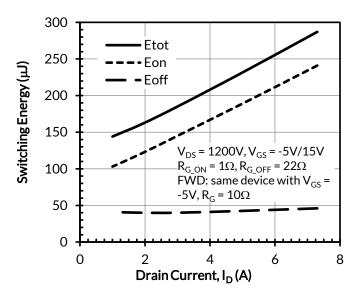


Figure 18. Clamped inductive switching energy vs. drain current at $T_J = 25$ °C

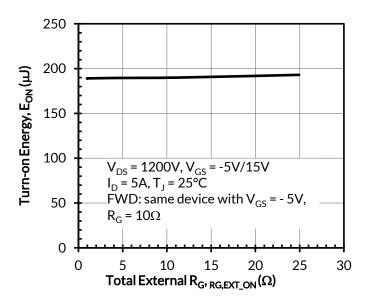


Figure 19. Clamped inductive switching turn-on energy vs. $R_{G,\text{EXT_ON}}$

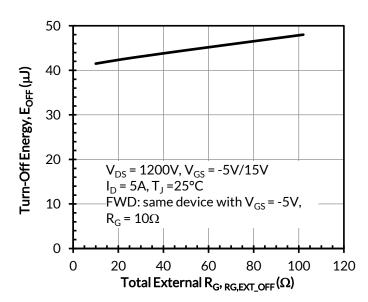


Figure 20. Clamped inductive switching turn-off energy vs. $R_{G,EXT\ OFF}$



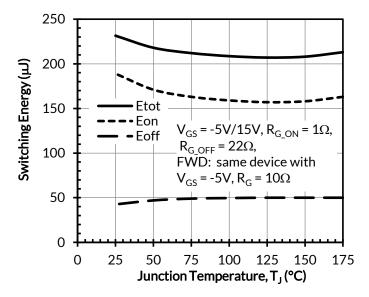












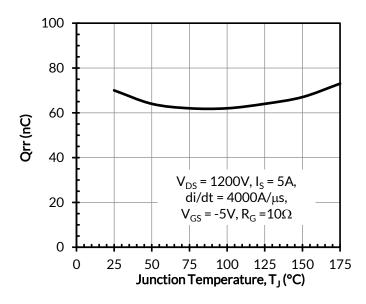


Figure 21. Clamped inductive switching energy vs. junction temperature at V_{DS} = 1200V and I_{D} = 5A

Figure 22. Reverse recovery charge Qrr vs. junction temperature

Applications Information

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{\rm DS(on)}$), output capacitance ($C_{\rm oss}$), gate charge ($Q_{\rm G}$), and reverse recovery charge (Qrr) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com.

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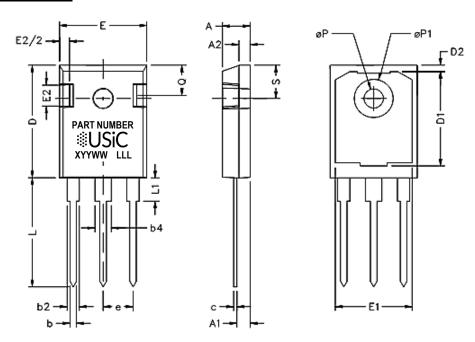
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TO-247-3L PACKAGE OUTLINE, PART MARKING AND TUBE SPECIFICATIONS

PACKAGE OUTLINE

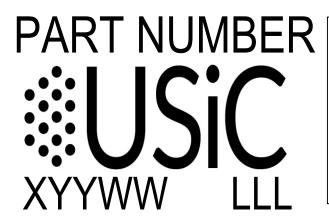


SYM	INC	HES	MILLIMETERS		
	MIN	MAX	MIN	MAX	
Α	0.185	0.209	4.699	5.309	
A1	0.087	0.102	2.21	2.61	
A2	0.059	0.098	1.499	2.489	
b	0.039	0.055	0.991	1.397	
b2	0.065	0.094	1.651	2.388	
b4	0.102	0.135	2.591	3.429	
С	0.015	0.035	0.381	0.889	
D	0.819	0.845	20.803	21.463	
D1	0.515	-	13.081	-	
D2	0.02	0.053	0.508	1.346	
E	0.61	0.64	15.494 16.25		
е	0.214	4 BSC	5.44 BSC		
E1	0.53	-	13.462	-	
E2	0.135	0.157	3.429	3.988	
L	0.78	0.8	19.812 20.32		
L1	ı	0.177	- 4.496		
ØΡ	0.14	0.144	3.556	3.658	
ØP1	0.278	0.291	7.061	7.391	
Q	0.212	0.244	5.385	6.198	
S	0.243	3 BSC	6.17 BSC		



TO-247-3L PACKAGE OUTLINE, PART MARKING AND TUBE SPECIFICATIONS

PART MARKING



PART NUMBER = REFER TO
DS PN DECODER FOR DETAILS

X = ASSEMBLY SITE

YY = YEAR

WW = WORK WEEK

LLL = LOT ID

PACKING TYPE

ANTI-STATIC TUBE

QUANTITY /TUBE: 30 UNITS

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